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March 2015



FDD3670

100V N-Channel PowerTrench MOSFET

General Description

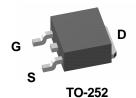
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

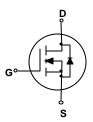
These MOSFETs f eature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(ON)}}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 34 A, 100 V. $R_{DS(ON)} = 32 \text{ m}\Omega$ @ $V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 35 \text{ m}\Omega$ @ $V_{GS} = 6 \text{ V}$
- Low gate charge (57 nC typical)
- · Fast switching speed
- High performance trench technology for extremely low R_{DS(ON)}
- · High power and current handling capability





Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter	Ratings		Units	
V _{DSS}	Drain-Source Voltage		100	V	
V _{GSS}	Gate-Source Voltage		±20	V	
I _D	Drain Current - Continuous	(Note 1)	34	Α	
	Drain Current - Pulsed	(Note 3)	100		
P _D	Maximum Power Dissipation @ T _C = 25°C	(Note 1)	83	W	
	@ T _A = 25°C	(Note 1a)	3.8		
	@ T _A = 25°C	(Note 1b)	1.6		
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +175	°C	

Thermal Characteristics

R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	1.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	96	°C/W

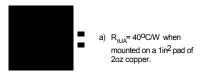
Package Marking and Ordering Information

_	Device Marking	Device	Reel Size	Tape width	Quantity	
	FDD3670	FDD3670	13"	16mm	2500 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	ource Avalanche Ratings (Note	2)	ı	I	ı	I
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 50 \text{ V}, \qquad I_D = 7.3 \text{ A}$			360	mJ
lar	Maximum Drain-Source Avalanche Current				7.3	Α
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C		92		mV/°C
loss	Zero Gate Voltage Drain Current	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$			10	μΑ
GSSF	Gate–Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate–Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	2.5	4	V
ΔV _{GS(th)} ΔT, _J	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C		-7.2		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, I_D = 7.3 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 7.3 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 6 \text{ V}, I_D = 7.0 \text{ A}$		22 39 24	32 56 35	mΩ
I _{D(on)}	On–State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V	25			Α
g FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 7.3 \text{ A}$	15	31		S
Dvnamic	Characteristics					
Ciss	Input Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V},$		2490		pF
Coss	Output Capacitance	f = 1.0 MHz		265		pF
C _{rss}	Reverse Transfer Capacitance			80		pF
Switchin	g Characteristics (Note 2)			•		•
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 50 \text{ V}, \qquad I_D = 1 \text{ A},$		16	26	ns
tr	Turn-On Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		10	18	ns
$t_{d(off)}$	Turn-Off Delay Time			56	84	ns
t _f	Turn–Off Fall Time			25	40	ns
Qg	Total Gate Charge	$V_{DS} = 50 \text{ V}, \qquad I_{D} = 7.3 \text{ A},$		57	80	nC
Q _{gs}	Gate–Source Charge	V _{GS} = 10 V		11		nC
Q_{gd}	Gate-Drain Charge			15		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain-Source	<u> </u>			2.7	Α
V _{SD}	Drain–Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.7 A (Note 2)		0.72	1.2	V

Notes

 R_{BIA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BIC} is guaranteed by design while R_{BCA} is determined by the user's board design.





b) $R_{\theta JA}$ = 96°C/W on a minimum mounting pad.

Scale 1: 1 on letter size paper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%
- ${\bf 3.}\ {\sf Pulse}\ {\sf Id}\ {\sf refers}\ {\sf to}\ {\sf Figure.9}\ {\sf Forward}\ {\sf Bias}\ {\sf Safe}\ {\sf Operation}\ {\sf Area}.$

Typical Characteristics

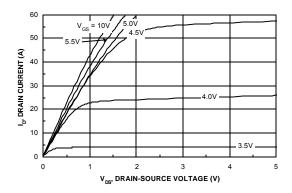
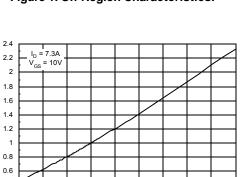


Figure 1. On-Region Characteristics.



75 100

T, JUNCTION TEMPERATURE (°C)

125 150

R_{DS(ON)} NORMALIZED DRAIN-SOURCE ON-RESISTANCE

-25

0

-50

Figure 3. On-Resistance Variation with Temperature.

25 50

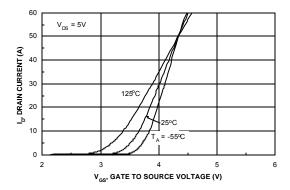


Figure 5. Transfer Characteristics.

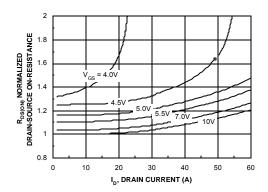


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

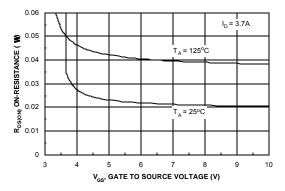


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

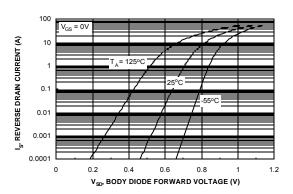
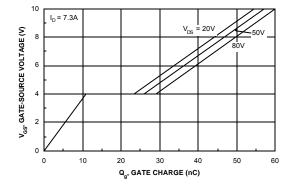


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



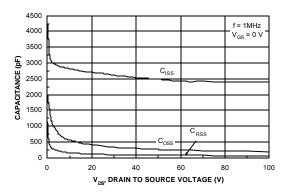


Figure 7. Gate Charge Characteristics.

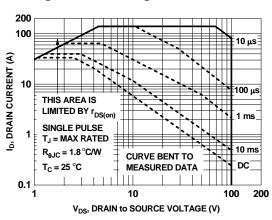


Figure 8. Capacitance Characteristics.

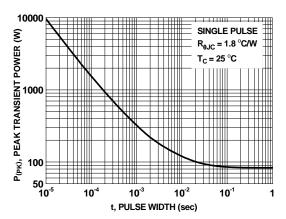


Figure 9. Forward Bias Safe Operating Area.



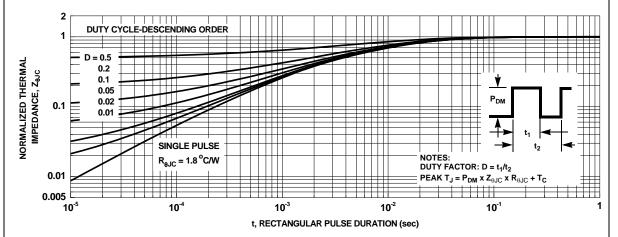


Figure 11. Junction-to-Case Transient Thermal Response Curve



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